Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination FURUKAWA, TAKASHI	
10/813,215		
Examiner	Art Unit	
James A. Fletcher	2621	

	SEAR	CHED	
Class	Subclass	Date	Examiner
386	6, 68, 46, 125	3/23/2006	JAF

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Tommy Chin regarding 101 and 112 issues with claim 10	4/13/2006	JAF	